

<b>Notice of References Cited</b>	Application/Control No. 10/666,478	Applicant(s)/Patent Under Reexamination SCHMID ET AL.	
	Examiner Phillip Nguyen	Art Unit 2828	Page 1 of 1

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*	C	US-2004/0208217	10-2004	Brick et al.	372/050
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	K	US-			
	L	US-			
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**NON-PATENT DOCUMENTS**

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